

Extending computational complexity theory to include thermodynamic resource costs

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with

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for Theoretical Physics

For continuous-time Markov chains sending $p(0)$ to $p(1) = \sum_j P(i | j) p_j(0)$

Van denBroeck and Esposito, *Physica A*, 2015

For many non-Markovian chains sending $p(0)$ to $p(1) = \sum_j P(i | j) p_j(0)$

Ptaszynski and Esposito, *PRL*, 2019

$$-\Delta Q = \Delta \Sigma - \Delta S$$

- $\Delta S = S(p_1) - S(p_0)$ is gain in **Shannon entropy** of p
- $-\Delta Q$ is (Shannon) **entropy flow** from system between $t = 0$ and $t = 1$
- $\Delta \Sigma$ is total **entropy production** in system between $t = 0$ and $t = 1$
 - **cannot be negative**
(I.e., the second law of thermodynamics)

GENERALIZED LANDAUER BOUND

- System connected to multiple reservoirs, e.g., heat baths at different temperatures. (So “ $k_B T$ ” not defined.)
- Arbitrary number of states
- Arbitrary initial distribution p_0
- Arbitrary dynamics $P(x_1 | x_0)$

$$-\Delta Q = \Delta\Sigma + S(p_0) - S(p_1)$$

Entropy Production ($\Delta\Sigma$) is non-negative. So:

“Generalized Landauer's bound”

$$-\Delta Q \geq S(p_0) - S(p_1)$$

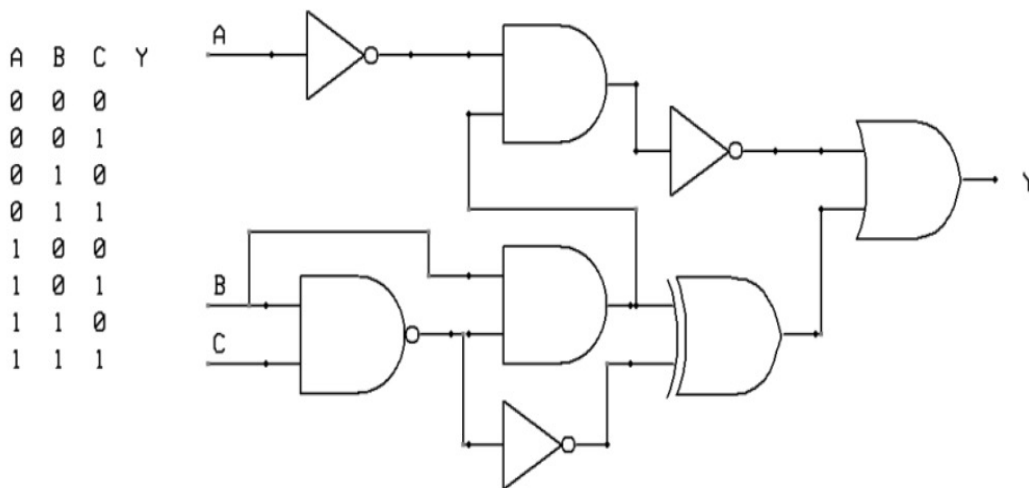
BOOLEAN CIRCUITS

- Currently, all mass-produced computers are implemented with circuits.
- The simplest circuit is one without loops or branches (a “straight-line program”)
- If set of allowed gates are a universal basis (e.g., NAND gates), then can build a circuit with them to implement any desired Boolean function.



$$-\Delta Q = \Delta\Sigma + S(p_0) - S(p_1)$$

- For fixed $P(x_1 | x_0)$, changing p_0 changes Landauer cost, $S(p_0) - S(p_1)$
- N.b., the same $P(x_1 | x_0)$ - e.g., same AND gate - has different p_0 , depending on where it is in a circuit.
- So even for a thermo. reversible gate ($\Delta\Sigma(p_0) = 0$), **changing the gate's location in a circuit** (changes $S(p_0) - S(p_1)$ and so) **changes $-\Delta Q(p_0)$**

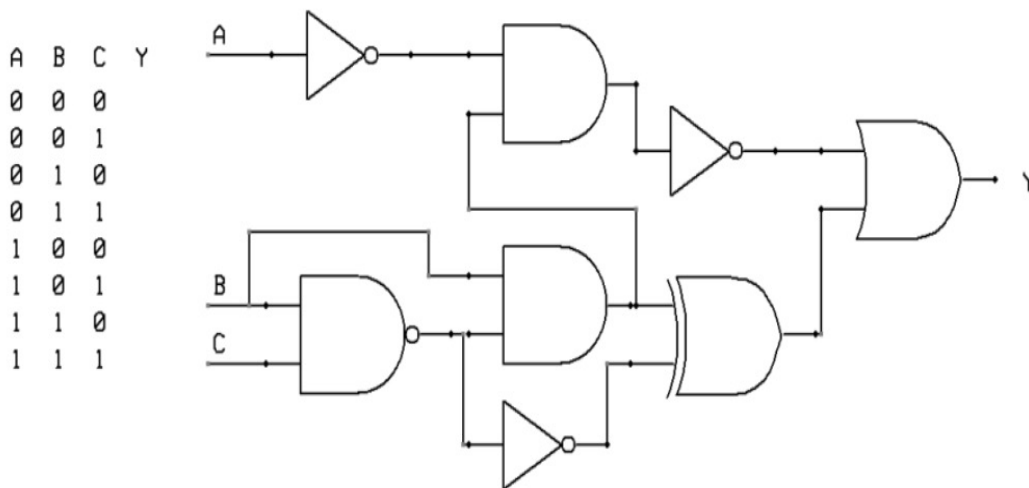


- Changing a gate's location in a circuit changes $S(p_0) - S(p_1)$, and so changes the heat it produces, $-\Delta Q(p_0)$
- Sum those heats over all gates to get minimal heat flow of that circuit

Different circuits implementing same Boolean function on same input distribution have different minimal heat

- Formally, those differences in minimal heat of the circuits are differences in EPs of the circuits, arising due to modularity of gates

➤ A new circuit design optimization problem



Demaine, E., et al., *Comm. ACM*, 2016

- Considers a similar problem - but incorrectly sets Landauer cost at each gate to same value, $KT \ln(2)$.

WHAT IS *REALLY* IMPORTANT THERMODYNAMICALLY?

$$-\Delta Q = \Delta \Sigma + S(p_0) - S(p_1)$$

- System evolves while connected to single heat bath at temperature T
 - Then heat flow into environment = $-k_B T \Delta Q$
- At scale of real computers and brains, $k_B T [S(p_0) - S(p_1)]$ is small
- At scale of real computers and brains, $\Delta \Sigma$ **is dominant cost**
 - Generalized Landauer's bound often irrelevant (it assumes $\Delta \Sigma = 0!$)

What determines $\Delta \Sigma$?

BEYOND GENERALIZED LANDAUER

- System connected to multiple reservoirs, e.g., heat baths at different temperatures. (So “ $k_B T$ ” not defined.)
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Entropy Production ($\Delta\Sigma$) is non-negative.

Are there broadly applicable non-negative lower bounds on $\Delta\Sigma$, to complement Landauer's bound?

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- Yes.

BEYOND GENERALIZED LANDAUER

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Entropy Production ($\Delta\Sigma$) is non-negative.

Are there broadly applicable non-negative lower bounds on $\Delta\Sigma$, to add to the lower bound $-\Delta Q \geq S(p_0) - S(p_1)$?

- Yes.
 - Focus on two: **Speed limit theorem** (SLT) and **Mismatch cost**

Use them to investigate the (thermodynamic) resource costs of computational machines

Original speed limit theorem (SLT): $\Delta\Sigma \geq \frac{L(p(0), p(1))}{A_{0,1}}$

- $L(p(0), p(1))$: L_1 distance from distribution $p(0)$ to distribution $p(1)$
- $A_{0,1}$: total number of (stochastic) state jumps from $t = 0$ to $t = 1$

Since introduced, SLT has been strengthened several ways (more complicated formulas).

Shiraishi, N., Funo, K.; Saito, K., *PRL* (2018)

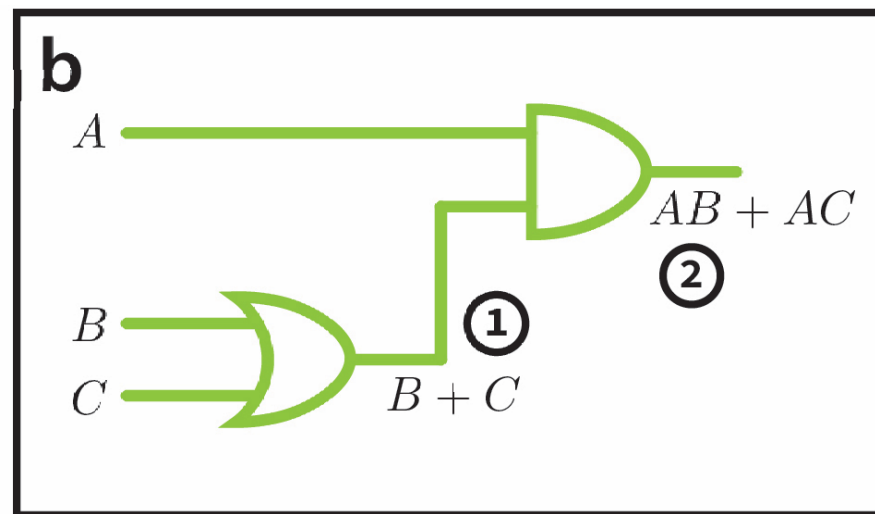
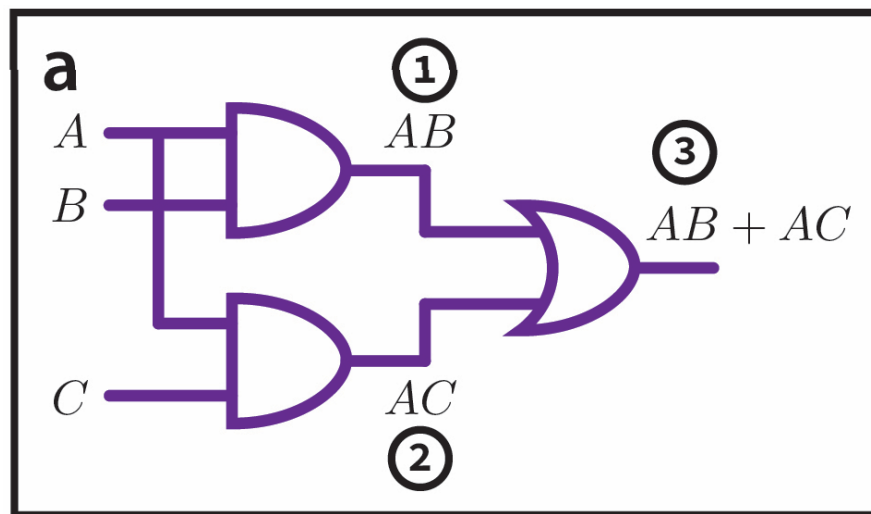
Delvenne, J., Falasco, G.; arXiv:2110.13050

Lee, J., et al.; *PRL* (2022)

Van Vu, T., Saito, K.; *PRL* (2023)

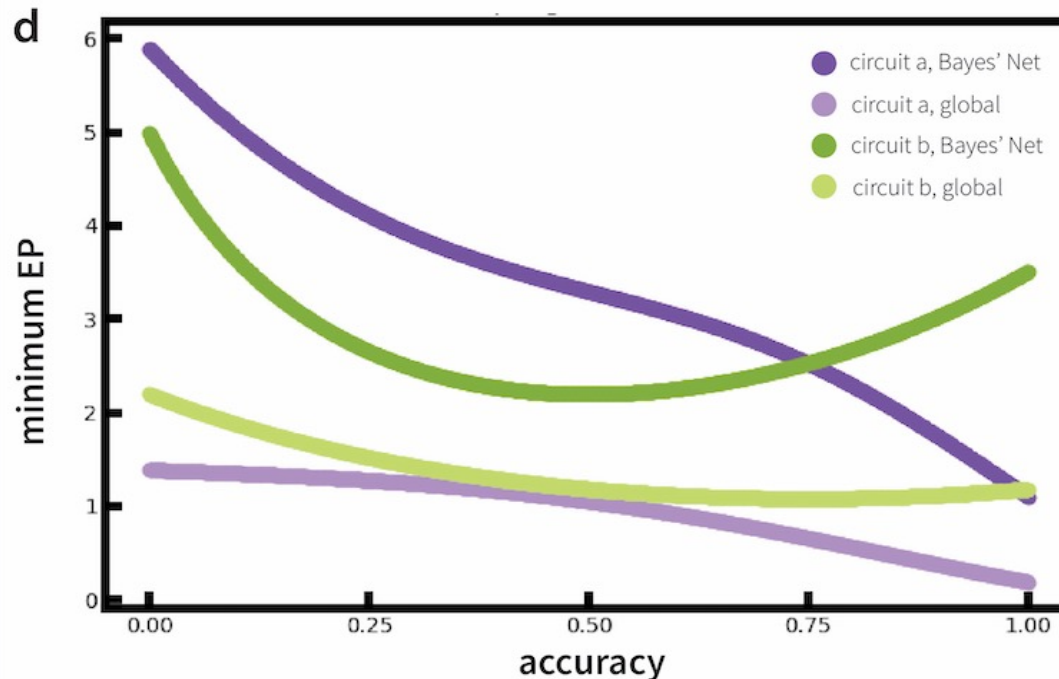
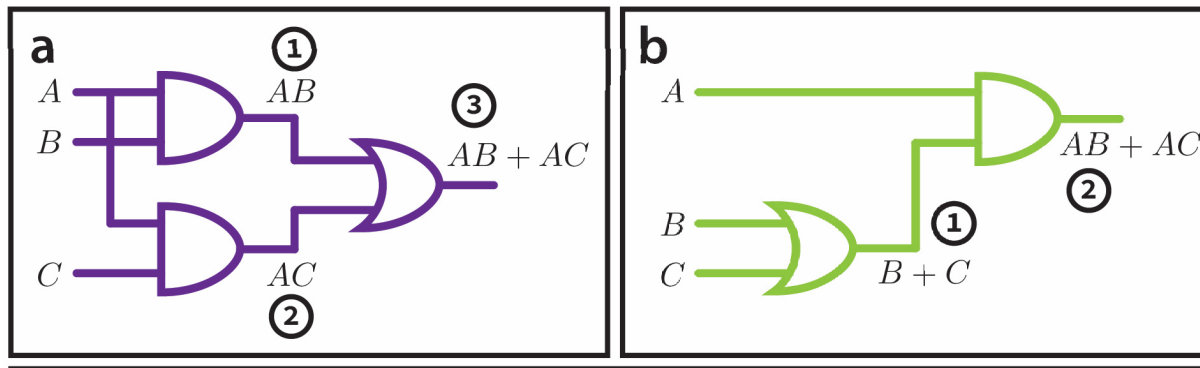
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- $A_{0,1}$: total number of (stochastic) state jumps from $t = 0$ to $t = 1$
- Suppose uniform initial distribution over all gates and input bits;
- How does the (Lee et al.) SLT bound vary with error rate of gates, for two logically equivalent circuits?



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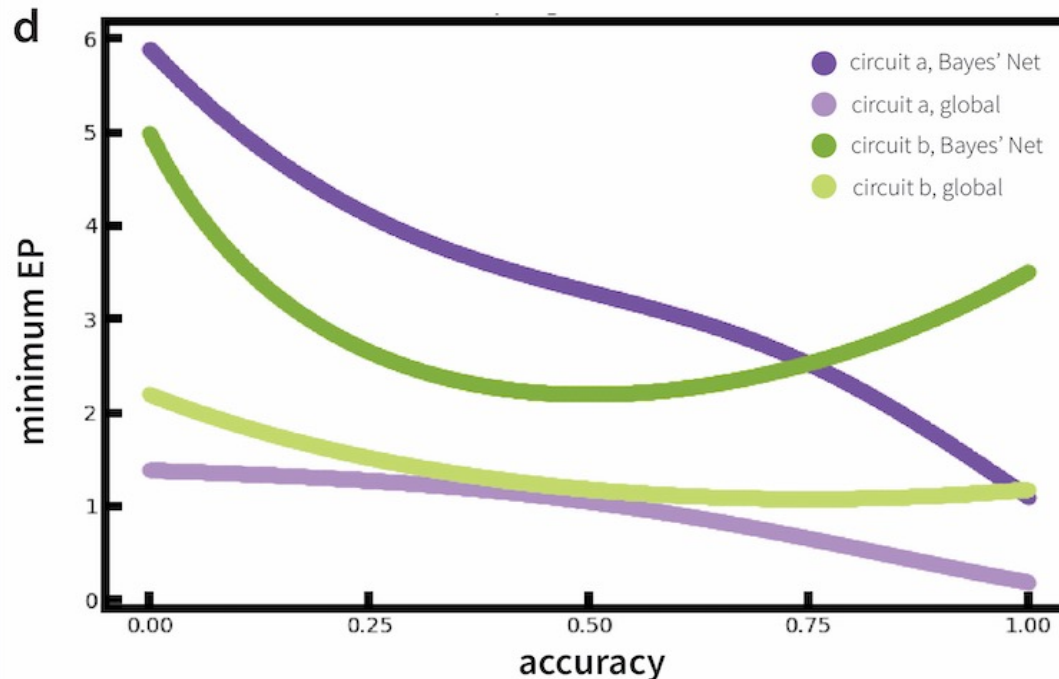
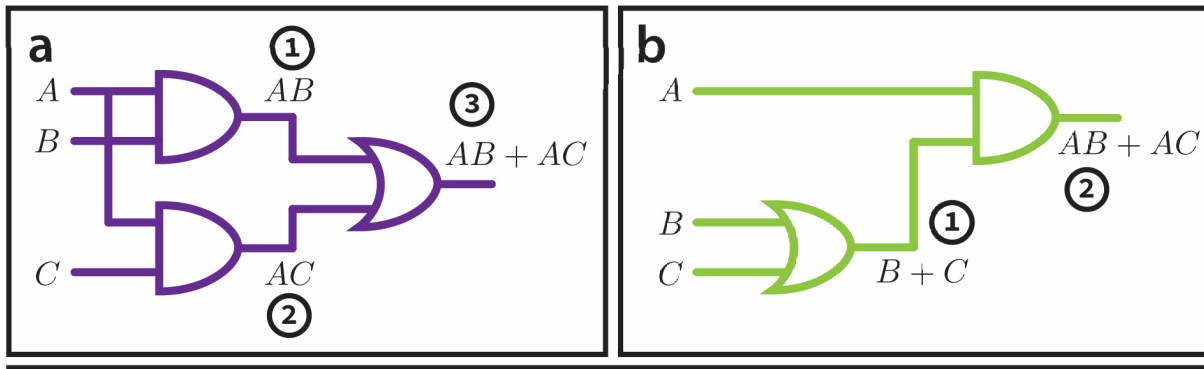
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Tasnim, F., Wolpert, D., Korbel J., Lynn, C., et al. (2023)

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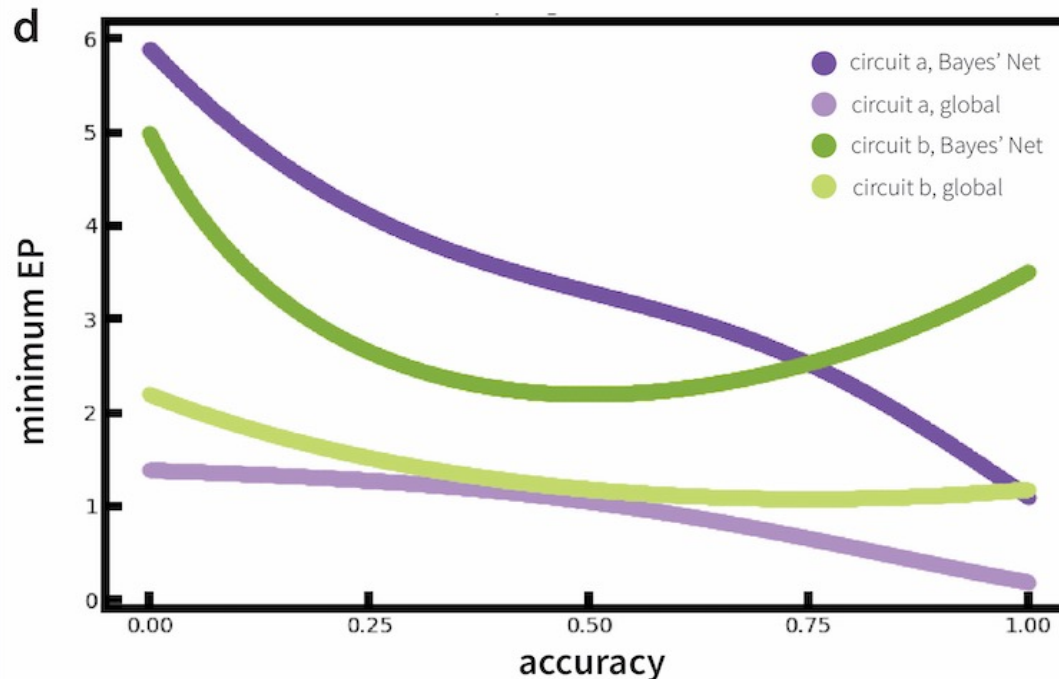
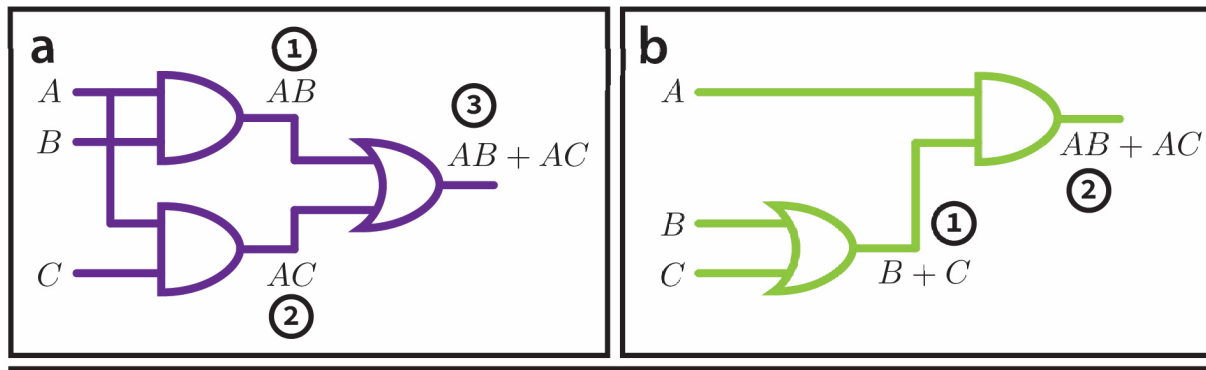
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What causes the curves to have these shapes?
 What are curves for other circuits?

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What causes the curves to have these shapes?
 What are curves for other circuits?

A: Who knows!

DEPENDENCE OF EP ON INITIAL DISTRIBUTION

- Arbitrary dynamics $P(x_1 | x_0)$
- **Assume system is thermo. reversible for initial distribution q_0**

i.e., $\Delta\Sigma(q_0) = 0$

- Run that system with initial distribution $p_0 \neq q_0$ instead:

$$\Delta\Sigma(p_0) = D(p_0 || q_0) - D(p_1 || q_1) \geq 0$$

where $D(. || .)$ is relative entropy (KL divergence)

Kolchinsky, A, Wolpert D., *J. Stat. Mech.* (2017)
Wolpert, D., Kolchinsky, A., *New J. Phys.* (2020)
Riechers, P., Gu, M., *Phys. Rev. E* (2021)
Kolchinsky, A., Wolpert D., *arxiv:2103.05734*

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$D(p_0 \parallel q_0) - D(p_1 \parallel q_1)$ is called **mismatch cost**

Wolpert, D., Kolchinsky, A., *New J. Phys.* (2020)

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Any nontrivial process that is thermodynamically reversible for one initial distribution ***will be costly*** for any other initial distribution

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Holds for master equations, Langevin dynamics, (open) quantum thermodynamics, inclusive (Hamiltonian) dynamics – pretty much everything.

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Same formula (just different prior q) for nonadiabatic EP, net lost free energy, etc.

EXAMPLE: Mismatch cost for parallel bit erasure

- **Two** distinct bit-erasing gates, each with thermo. rev. initial distribution q_0
- Run gates in parallel, on bits x^A and x^B , with initial distribution $p_0(x^A, x^B)$
- Assume $p_0(x^A) = q_0(x^A)$ and $p_0(x^B) = q_0(x^B)$.
- So each gate, by itself, generates zero EP. But:

*If $p_0(x^A, x^B)$ statistically couples the bits, then full system is **not** thermo. reversible, and generates nonzero EP*

- **Formally:** Since gates are distinct, the thermo. rev. *joint* distribution is $q_0(x^A, x^B) = q_0(x^A)q_0(x^B)$

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- **Intuition:** Running two thermo. reversible gates in parallel loses information in their initial coupling, and so is not thermo. reversible.

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- **Broader lesson: Modularity increases EP**

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- **Broader lesson:** Whatever its practical benefits might be, **modularity is thermodynamically costly (!)**

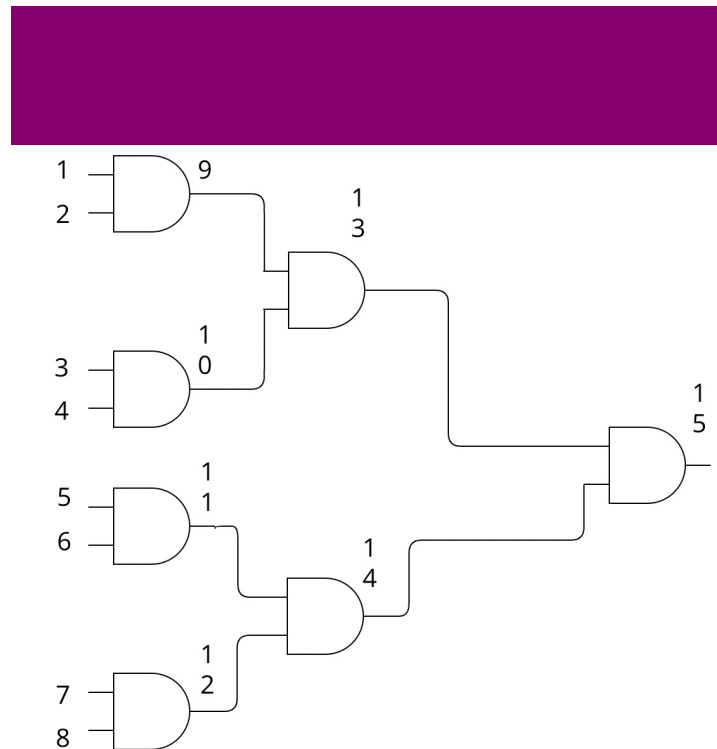
EXAMPLE: Mismatch cost for reusing a Boolean circuit

Over N periods, the sum-total mismatch cost (lower bound on EP) is:

$$\sum_{t=0}^{N-1} [D(P^t p_0 \parallel q) - D(P^{t+1} p_0 \parallel Pq)]$$

Gates are not reinitialized after being run; have old values when next run.
So assuming IID generation of input, $R(x_0)$, initially, joint distribution is

$$R(x) = R(x_0) R(x_{1,2,3} \mid x_0)$$



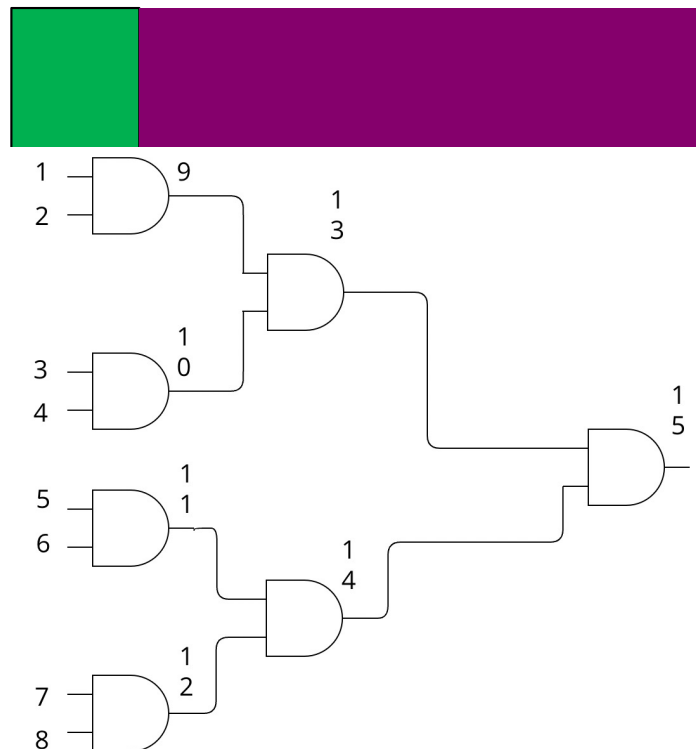
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So assuming IID generation of input, $R(x_0)$, after running 1st layer, joint distribution is

$$R(x) = R(x_0) R(x_{1,2,3})$$



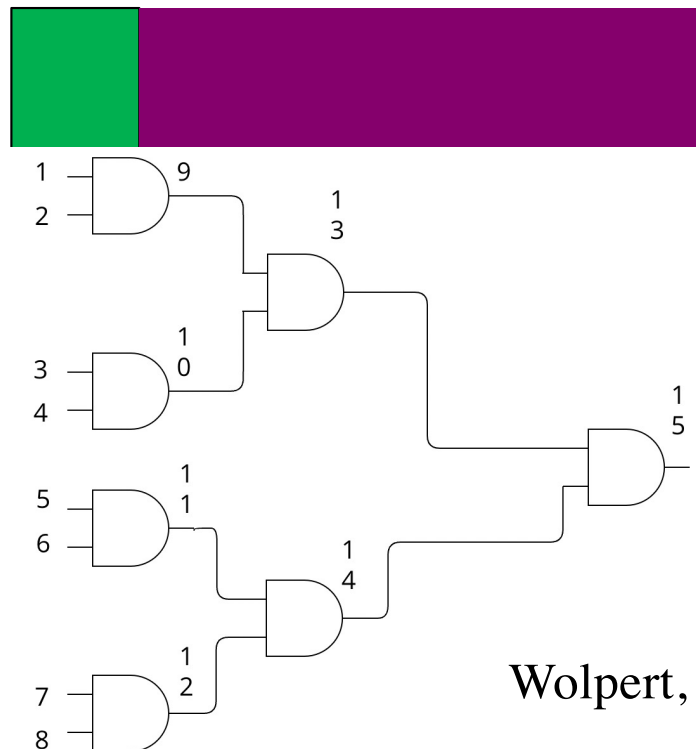
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So running 1st layer gives mismatch cost

$$D(R(x_0) R(x_{1,2,3} \mid x_0) \parallel q(x_0) q(x_{1,2,3} \mid x_0)) - D(R(x_0) R(x_{1,2,3}) \parallel R(x_0)q(x_{1,2,3})) \geq I_R(X_0 ; X_1, X_2, X_3)$$



Wolpert, D.H. *Phys. Rev. Letters*, **125**, (2020)

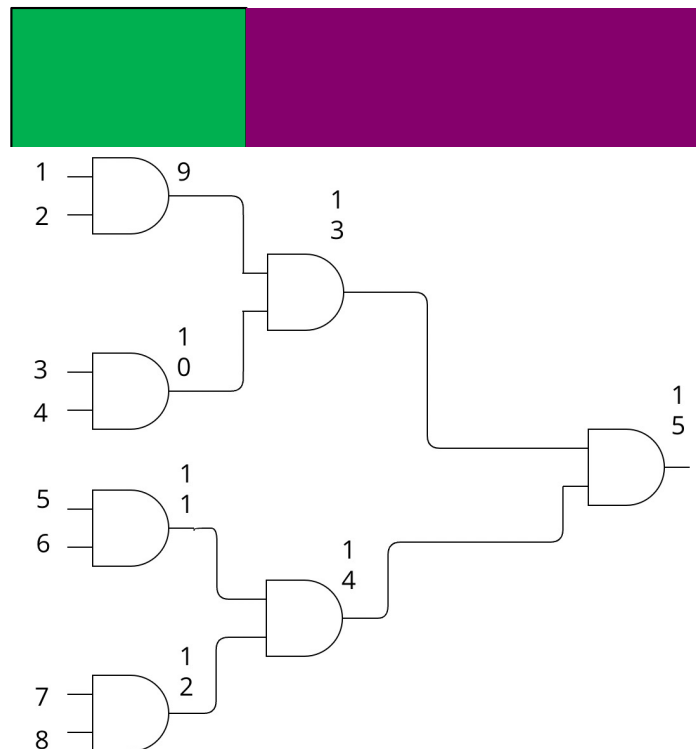
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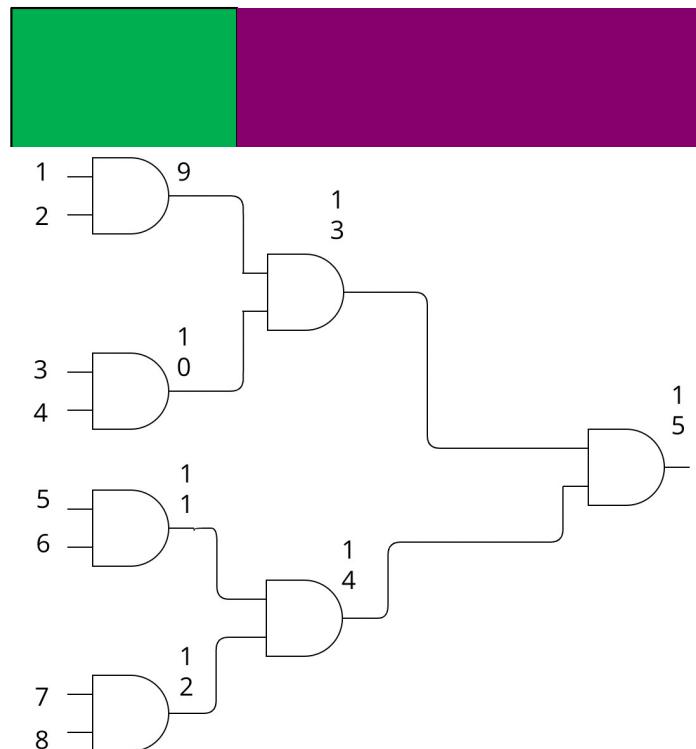
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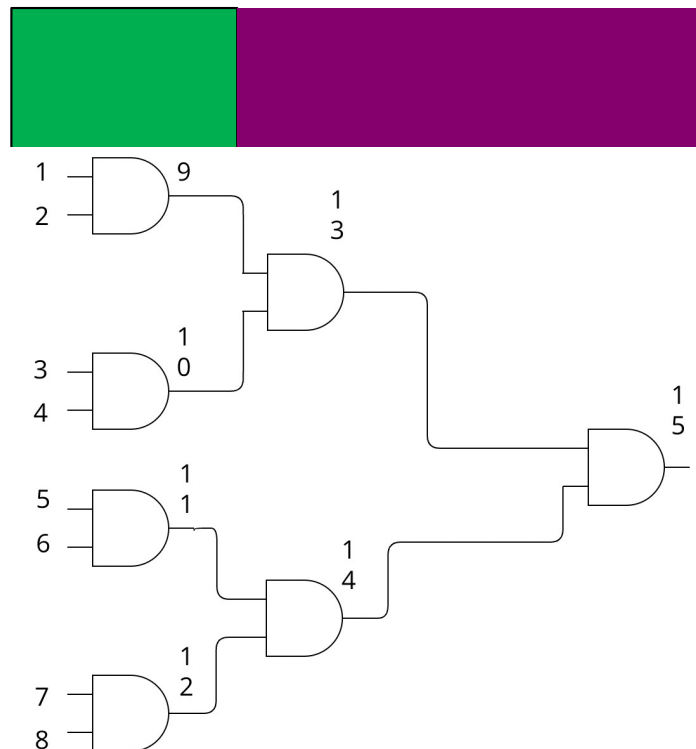
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Technical detail: Also is a variable saying which layer is currently being updated, which increments in each iteration

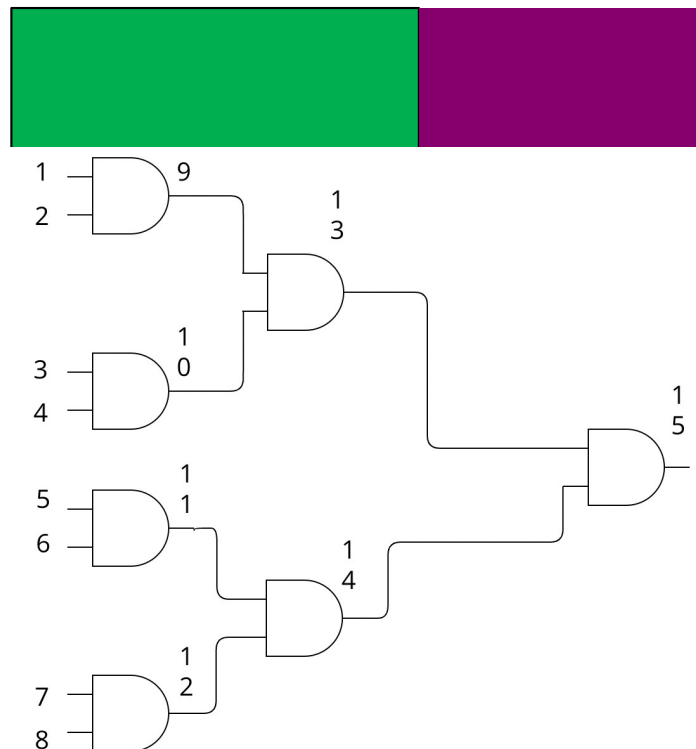
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$$R(x) = R(x_{0,1,2}) R(x_3)$$



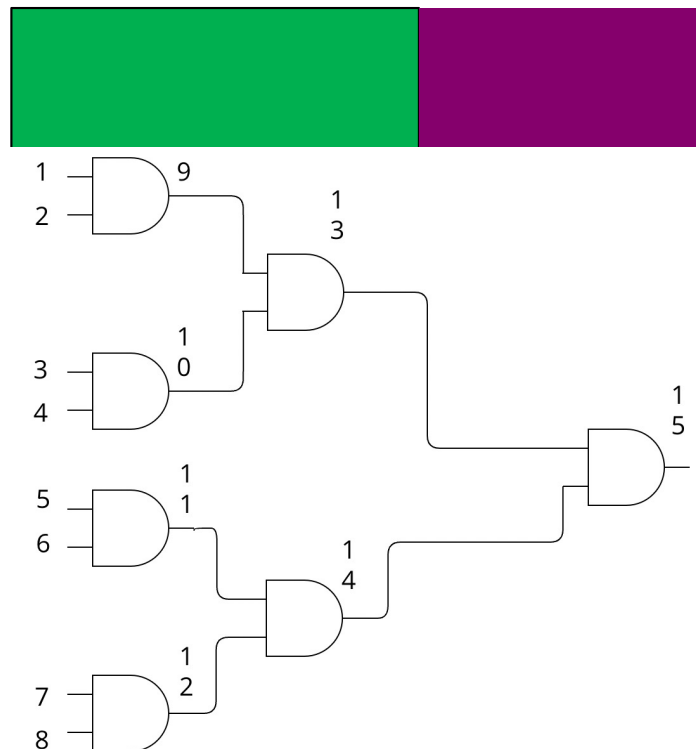
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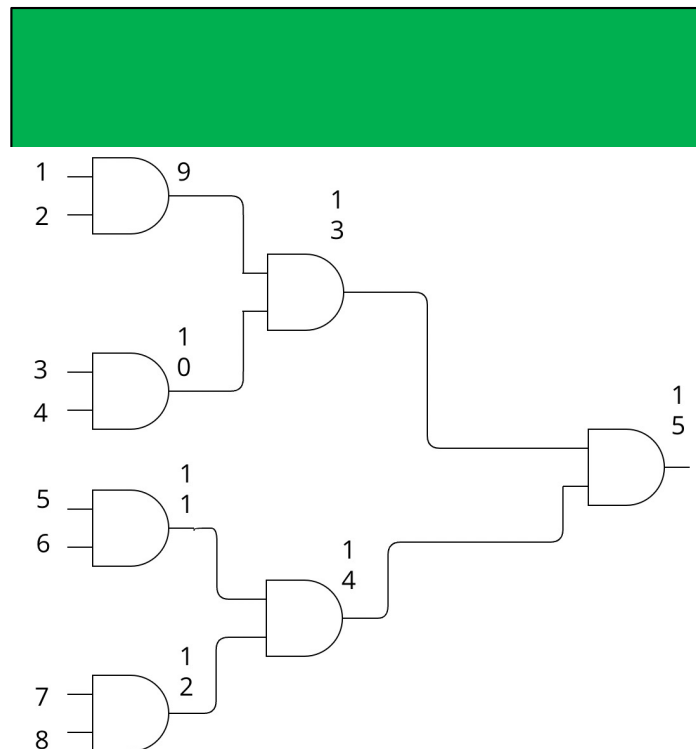
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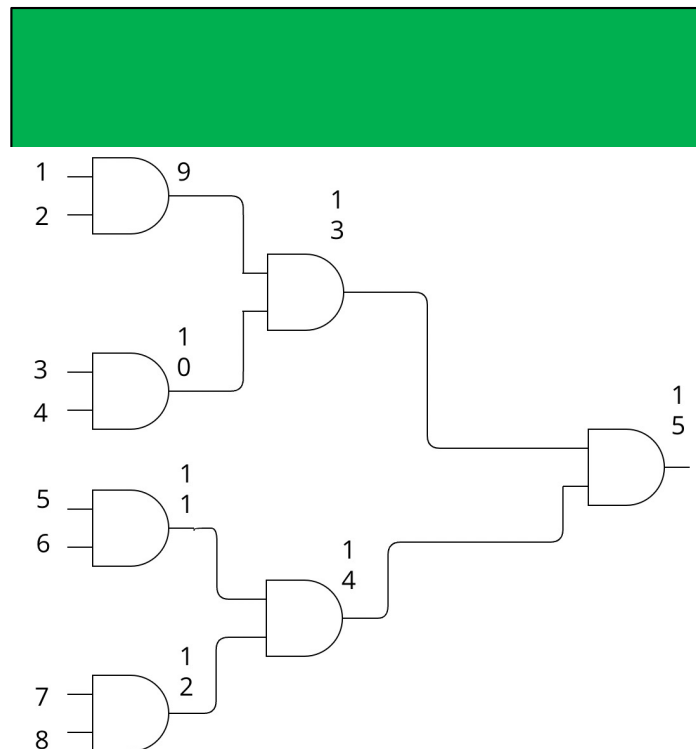
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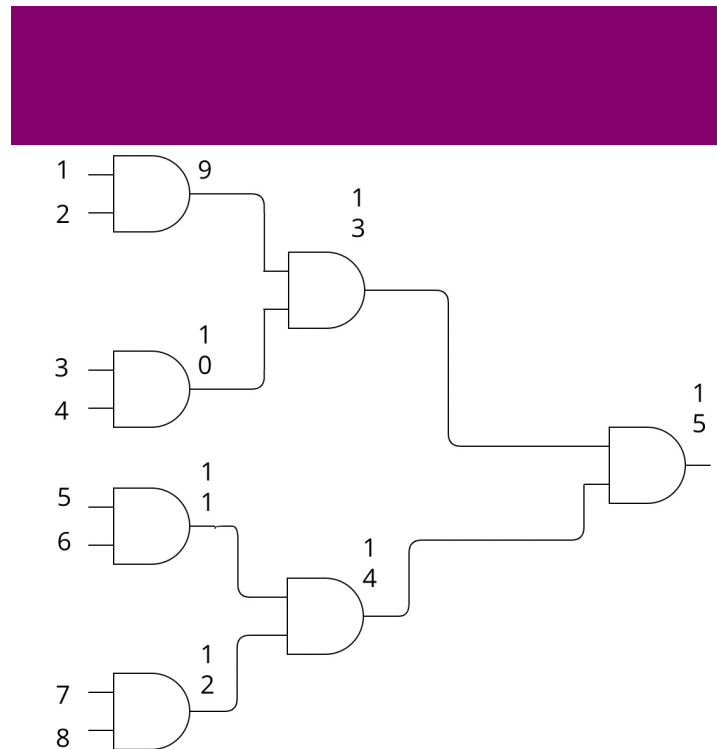
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$$R(x) = R(x_0)R(x_{1,2,3} \mid x_0) = R(x)$$



MISMATCH COST IN PERIODIC PROCESSES

A process over a space X that is periodic, with period λ . So for all n ,

$$P(x(n\lambda) | x((n-1)\lambda)) = P(x(\lambda) | x(0))$$

So over N periods, the sum-total mismatch cost (lower bound on EP) is:

$$\sigma(N\lambda) \geq \inf_{q \in \Delta_X} \sum_{t=0}^{N-1} [D(P^t p_0 || q) - D(P^{t+1} p_0 || Pq)]$$

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KEY POINT: Since the process is periodic, q is the same in each period. However, $P^t p_0$ will differ over periods.

Therefore

At most one mismatch cost in the sum can equal 0 in general

A process over a space X that is periodic, with period λ . So for all n ,

$$P(x(n\lambda) | x((n-1)\lambda)) = P(x(\lambda) | x(0))$$

So over N periods, the sum-total mismatch cost (lower bound on EP) is:

$$\sigma(N\lambda) \geq \inf_{q \in \Delta_X} \sum_{t=0}^{N-1} [D(P^t p_0 || q) - D(P^{t+1} p_0 || Pq)]$$

KEY POINT: Since the process is periodic, q is the same in each period. However, $P^t p_0$ will differ over periods.

Therefore

At most one mismatch cost in the sum can equal 0 in general

A new strictly positive lower bound on EP for any periodic process

A process over a space X that is periodic, with period λ . So for all n ,

$$P(x(n\lambda) | x((n-1)\lambda)) = P(x(\lambda) | x(0))$$

So over N periods, the sum-total mismatch cost (lower bound on EP) is:

$$\sigma(N\lambda) \geq N\Delta JS(\{P^t p_0\})$$

- JS is Jensen-Shannon divergence for uniform distribution over N periods

A new strictly positive lower bound on EP for *any* periodic process

Wolpert, D.H. *Phys. Rev. Letters*, **125**, (2020)

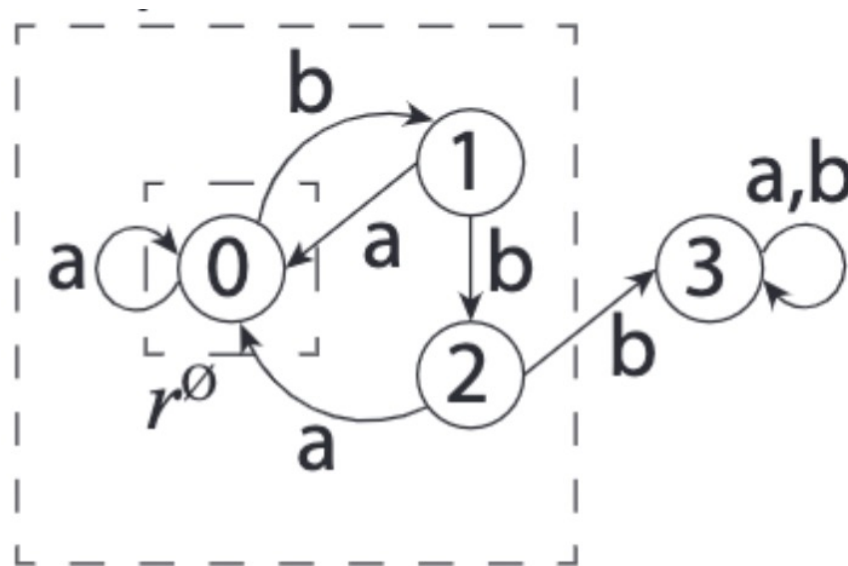
Ouldrige, T.; Wolpert, D.H., arxiv:2208.06895 (2022)

Tasnim, F.; Wolpert, D.H. *Entropy*, (2023)

Manzano, G., Kardes, G.; Roldan, E.; Wolpert, D.H., arxiv: 2307.05713 (2023)

DETERMINISTIC FINITE AUTOMATA (DFA)

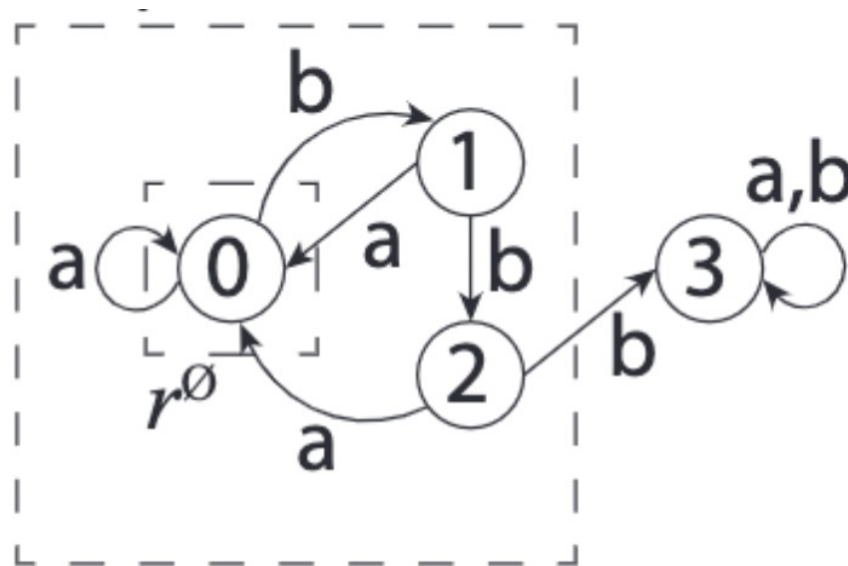
- **Simplest computational machine in Chomsky hierarchy**
 - Finite number of states; one **initial state**, multiple “**accept states**”
 - Feed in a finite string of bits;
 - Each (bit, state) pair maps to a new state, after which next bit is read
 - A DFA “**accepts**” a string if it causes the DFA to end in an accept state
 - “**Language**” of a DFA is all input strings that it accepts
 - Many languages that are not accepted by any DFA
- **Example:** DFA that accepts any string with no more than two successive ‘b’ bits:



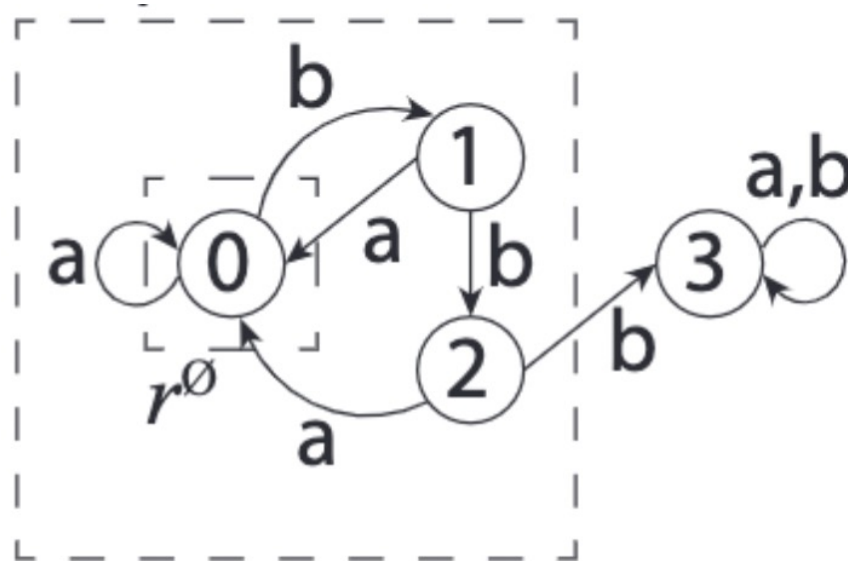
- *Every* digital computer is a **sequence of solitary processes**
 - Only part of the memory is physically to any processor at any time
 - So evolving subsystem is processor and current part of memory
- Results in **modularity (mismatch) cost** – just like parallel bit erasure
 - State space = {joint state of *full* memory and processor}

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Example: In a DFA, memory contains *entire* string of input symbols
 However, DFA state only physically coupled to *current* input symbol,
not earlier or later symbols in the string



- Every (synchronous) digital computer is “**periodic**”
 - Every successive iteration is the same physical process.
And so every iteration **has the same prior**
- E.g., in a DFA, every iteration has same prior
- So if prior distribution = actual distribution for iteration i , there is zero mismatch cost for iteration i **But:**
The distributions will differ for iteration $i + 1$ in general
- Results in “**periodicity (mismatch) cost**”

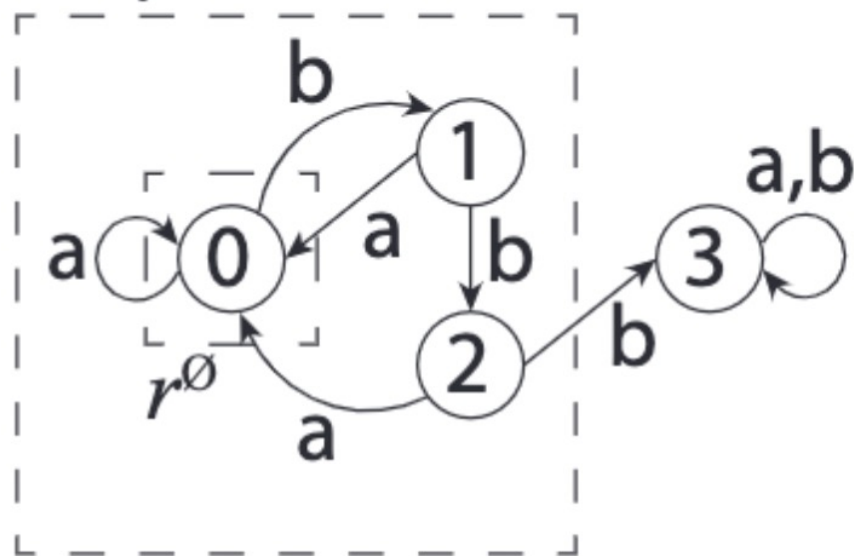


- Every (synchronous) digital computer is “**periodic**”
 - Every successive iteration is the same physical process.
And so every iteration **has the same prior**
- E.g., in a DFA, every iteration has same prior
- So if prior distribution = actual distribution for iteration i , there is zero mismatch cost for iteration i **But:**
The distributions will differ for iteration $i + 1$ in general
- Results in “**periodicity (mismatch) cost**”
- So, for any p_0 and any update conditional distribution P ,

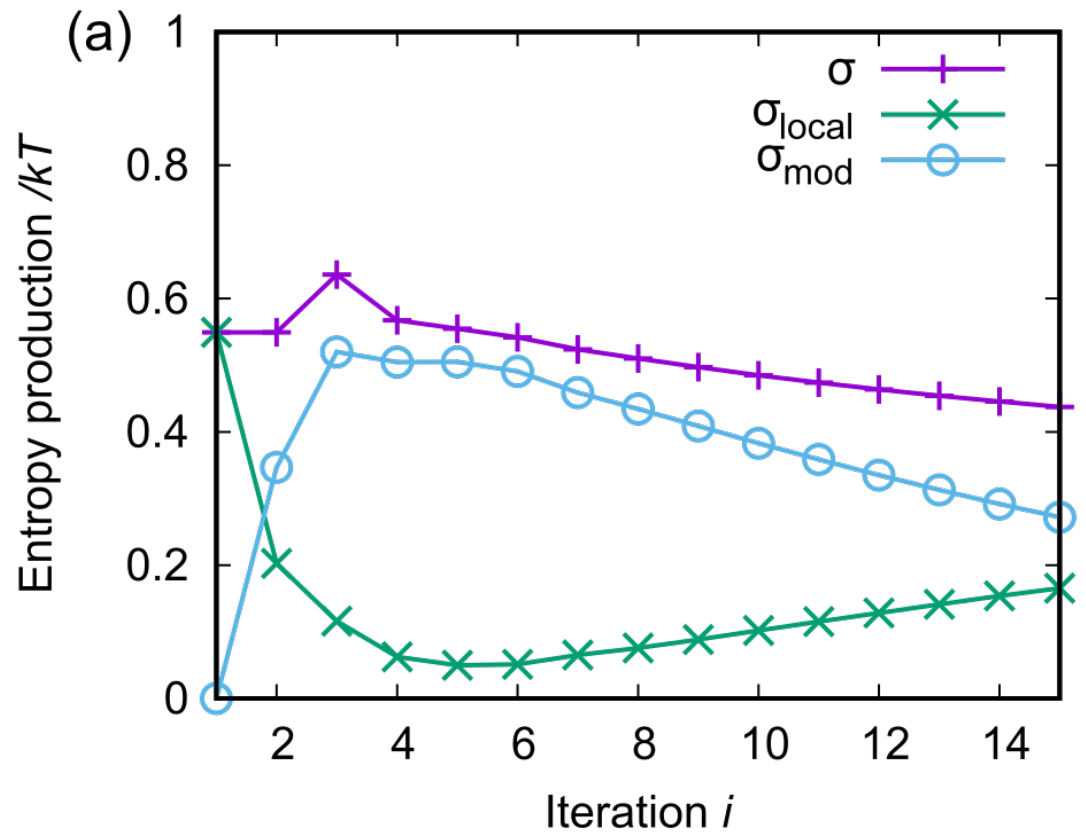
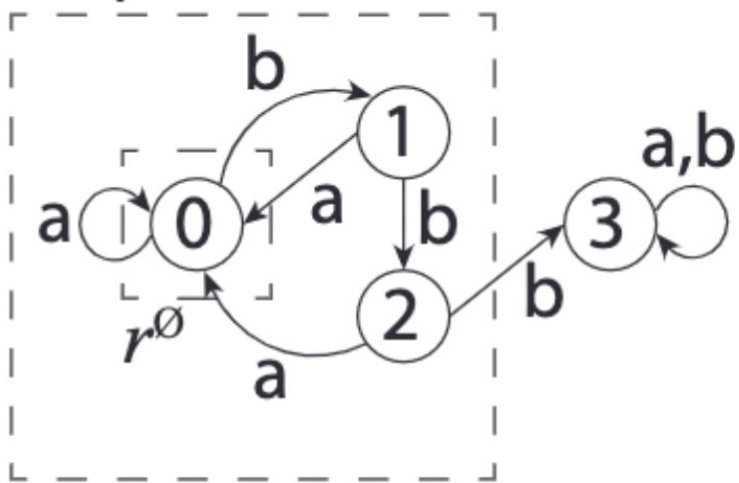
$$EP \geq \operatorname{argmin}_q \sum_{i=0}^n [D(P^i p_0 || q) - D(P^{i+1} p_0 || Pq)]$$

- Independent of the physical details of the underlying process
(just like generalized Landauer bound)
- In general, RHS is strictly positive

- Total mismatch cost = modularity cost + periodicity cost

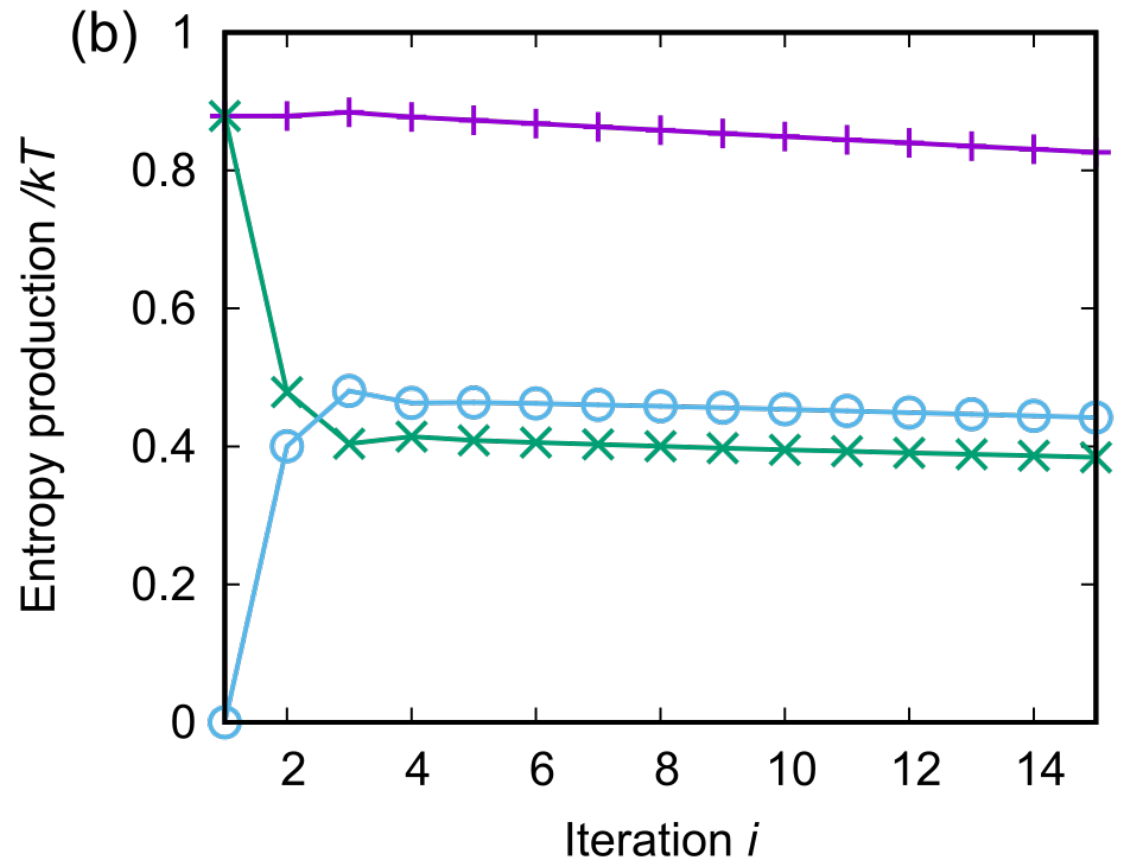
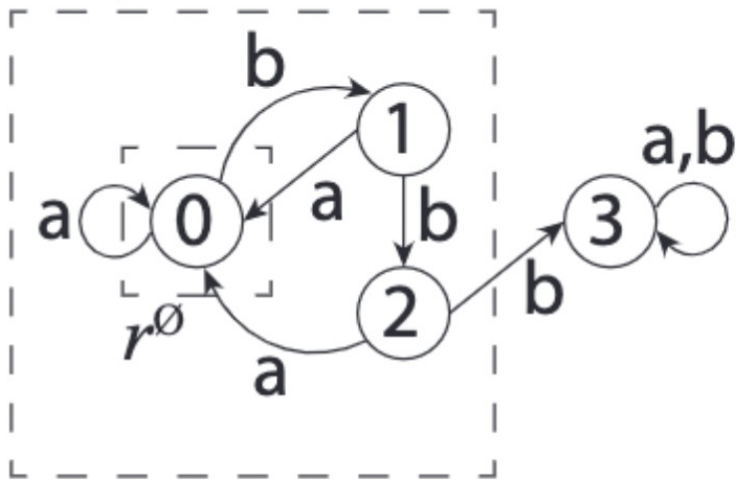


EXAMPLE



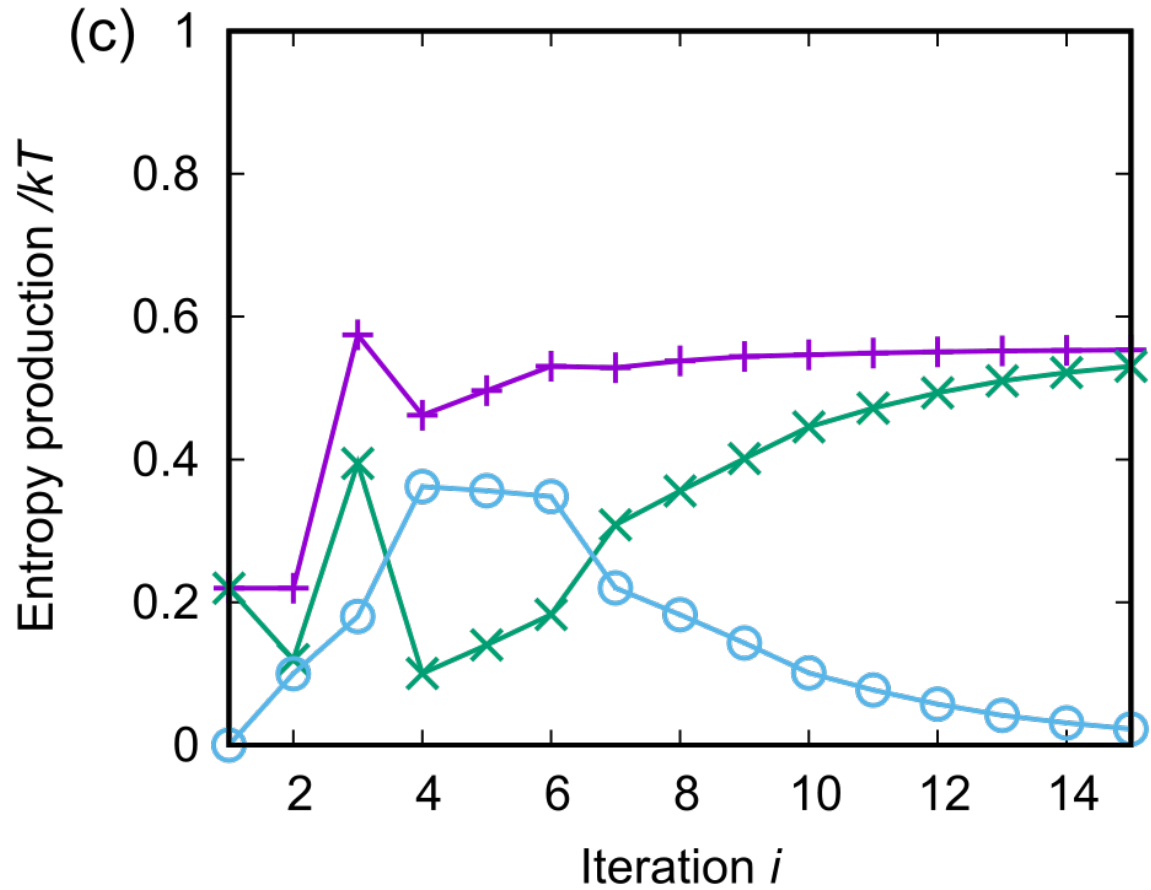
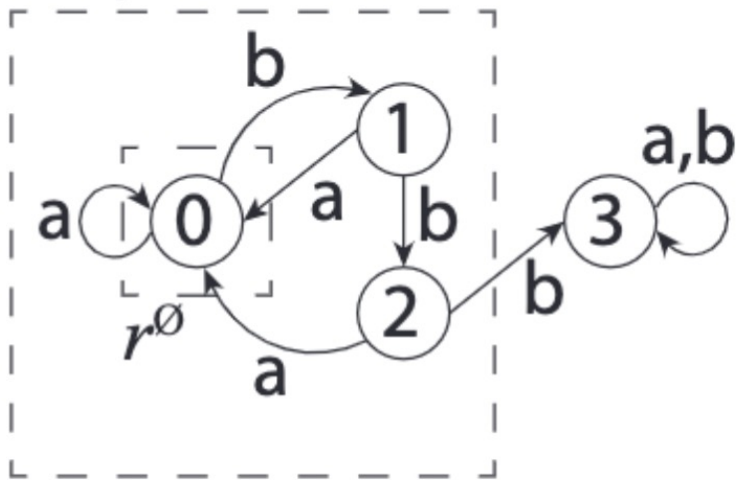
- Input strings have IID symbols with equal probability of a and b
- Uniform prior

EXAMPLE



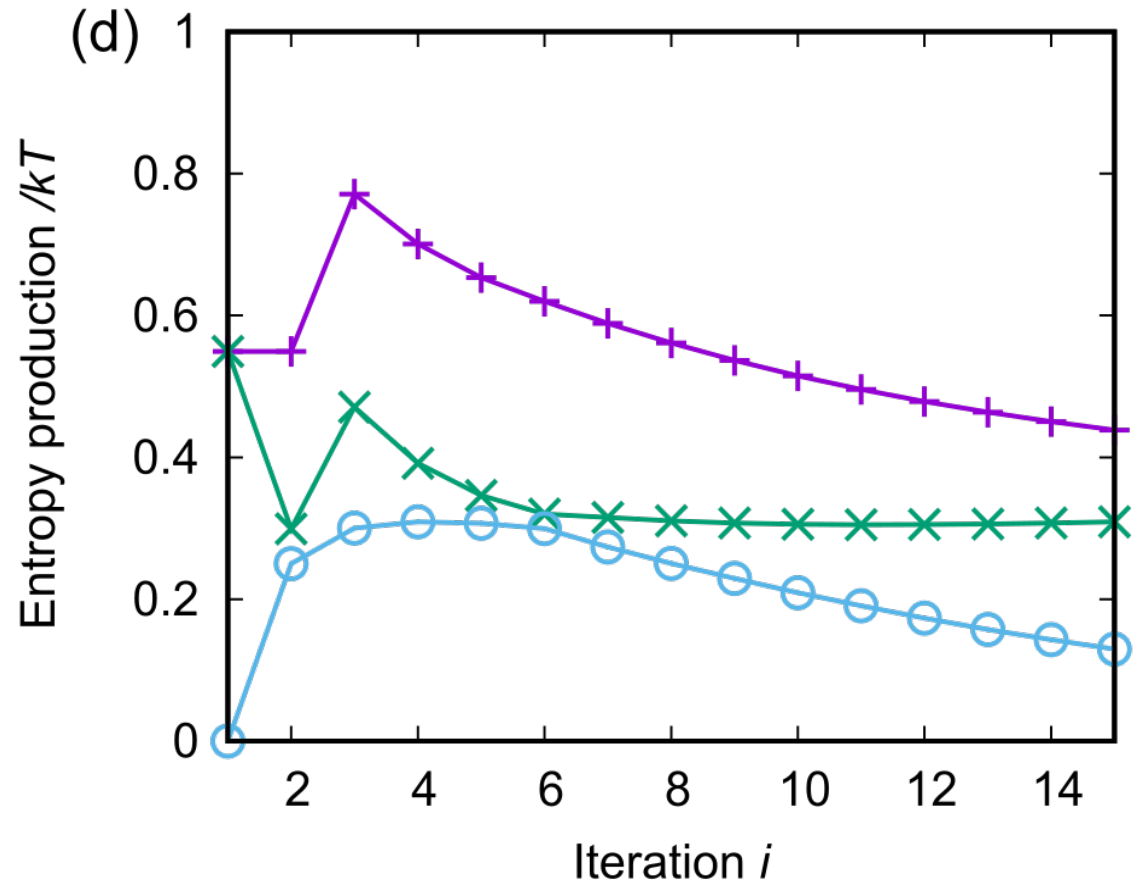
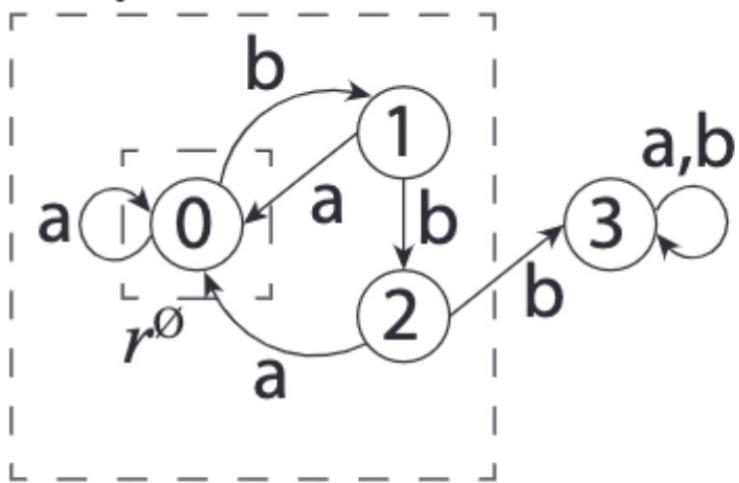
- Input strings have IID symbols with probability of $a = 0.8$

EXAMPLE



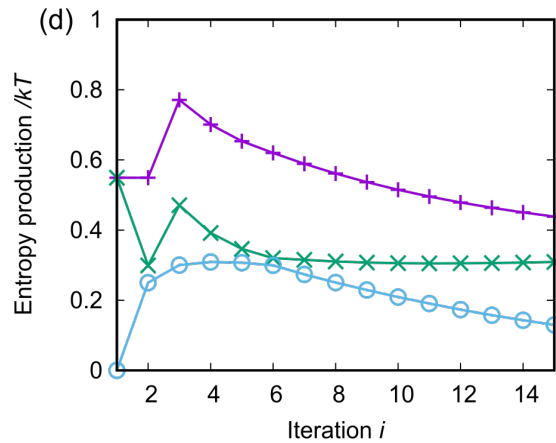
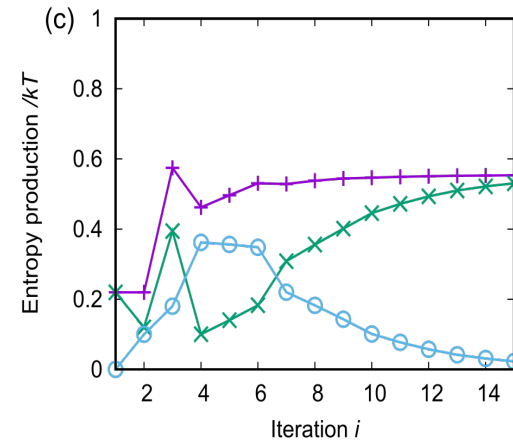
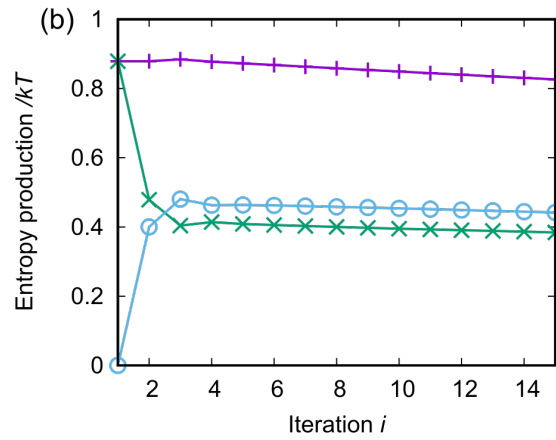
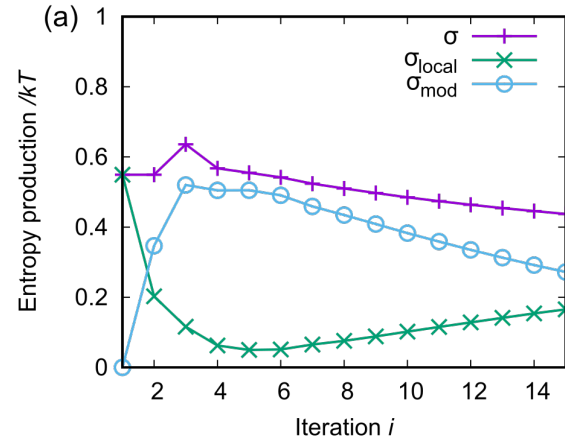
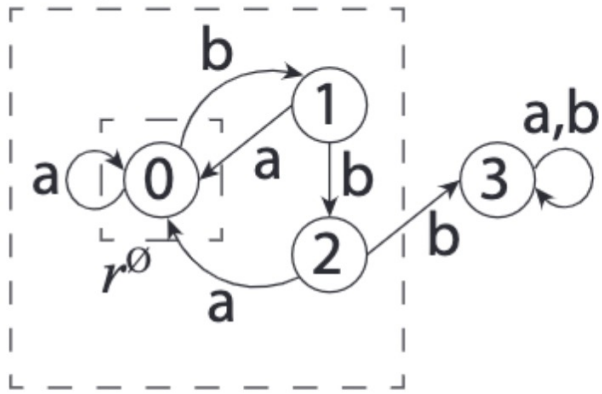
- Input strings have IID symbols with probability of $a = 0.2$

EXAMPLE



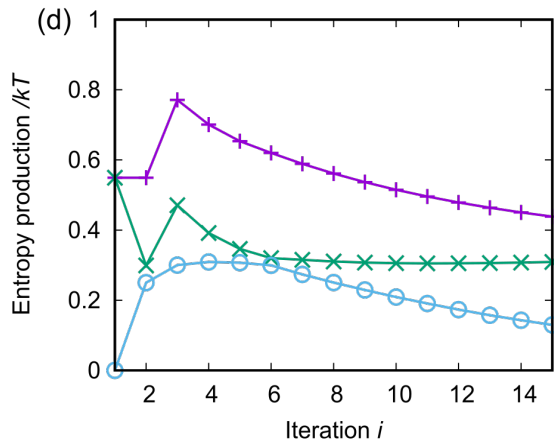
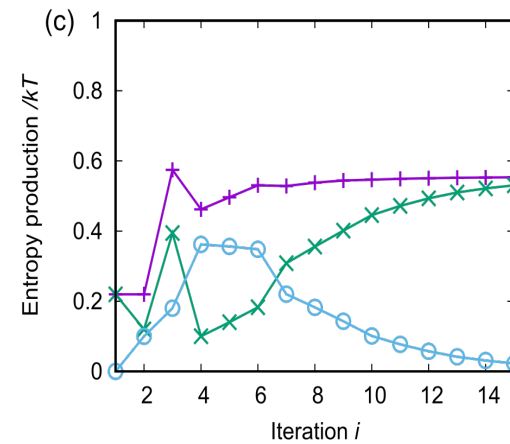
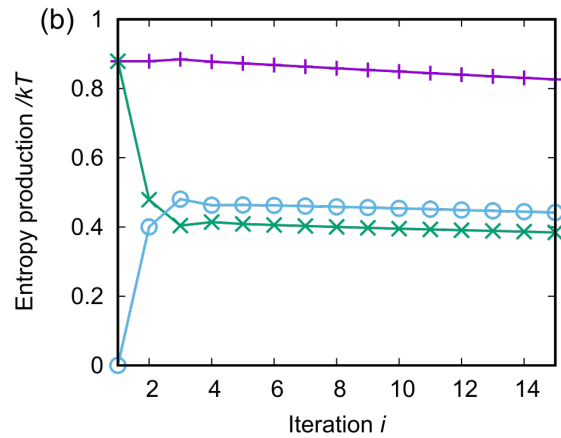
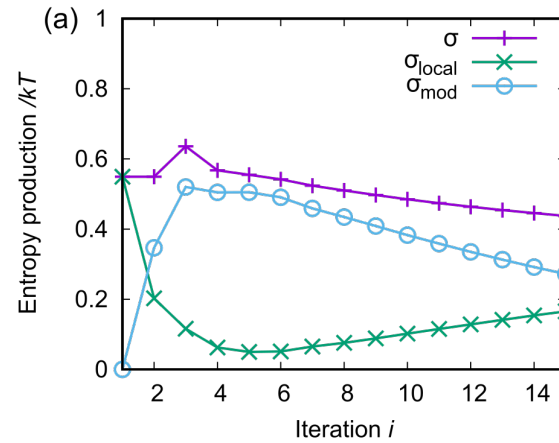
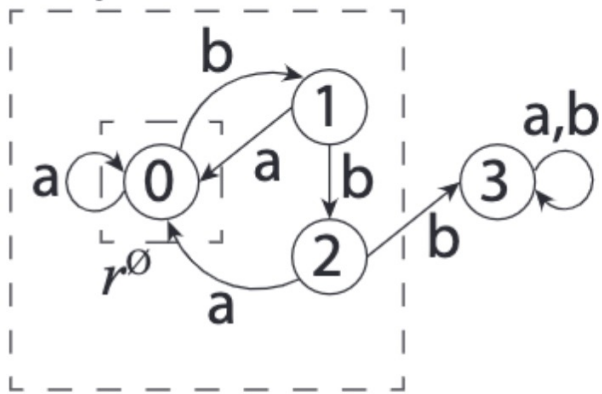
- Input strings are first order Markov chains (starting from uniform probability)

EXAMPLE



Ouldrige, T., Wolpert, D., arxiv:2208.06895 (2022)

EXAMPLE



What causes curves to have these shapes?
What are curves for other DFAs?

A: Who knows!

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